

Search Notes

Application/Control No.

10/614,056

Examiner

Chuck Huynh

Applicant(s)/Patent under
Reexamination

ANDO, TAKESHI

Art Unit

2683

SEARCHED

Class	Subclass	Date	Examiner
455	432.1	4/21	CH.
379	130	4/19	CH
455	417	4/19	CH
455	432.2	4/20	CH
704	257	4/20	CH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	4/21/05	CH.
Citations/IDS	4/19	CH.